## Notice of References Cited Application/Control No. 10/710,398 Examiner MICHAEL YAARY Applicant(s)/Patent Under Reexamination LEI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,293,558	03-1994	Narita et al.	708/605
*	В	US-4,805,128	02-1989	Nelsen et al.	708/204
*	С	US-5,317,526	05-1994	Urano et al.	708/204
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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